

SIM CARD CONNECTOR, BLOCK SIM, 0.30mm HEIGHT

1.0 SCOPE

This Product Specification covers the performance requirements of the SIM Card Connector (Block SIM).

2.0 PRODUCT DESCRIPTION

2.1 PRODUCT NAME AND SERIES NUMBER(S)

Product Name

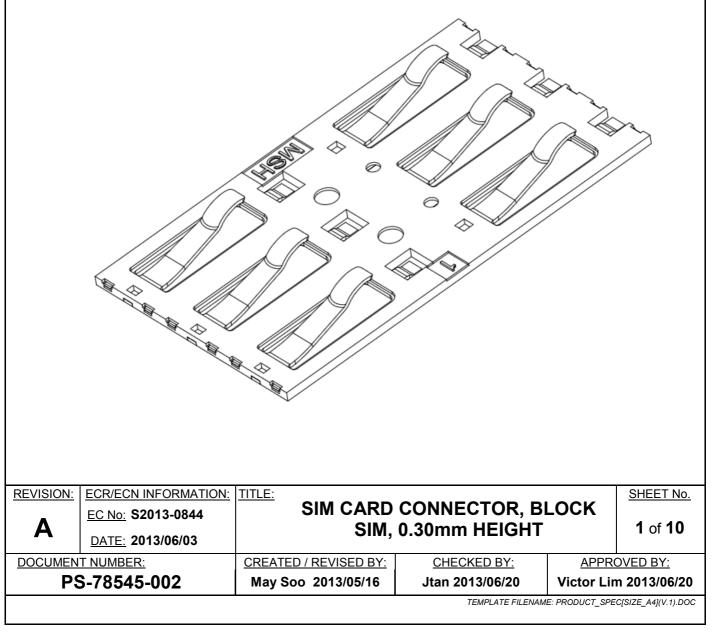
Series Number

SIM CARD CONNECTOR, BLOCK SIM, 0.30MM HEIGHT

78545

2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See Sales Drawing SD-78545-003 for information on dimensions, materials, platings and markings.





3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

The following documents form a part of this specification to the extended specified herewith. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence.

4.0 RATINGS

4.1 CURRENT RATING

0.5Amps Max. per contact

4.2 VOLTAGE RATING 15 Volt DC Max.

4.3 TEMPERATURE

Operating: - 30°C to + 85°C Storage (with packaging): - 5°C to + 85°C

5.0 MECHANICAL INTERFACE

5.1 CARD INTERFACE

SIM card interface: GSM 11.11 specification

5.2 PWB INTERFACE

Plating on PWB pads: OSP plated copper

6.0 PERFORMANCE

6.1 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Low Level Contact Resistance (LLCR)	Mate connectors with dry circuit (20 mV, 100mA MAX) at 0.30mm away from housing top surface (see appendix 1) (IEC 60512-2-1)	100 milliohm [MAXIMUM] [initial] Value includes bulk resistance of terminal
2	Insulation Resistance	Unmated connectors: apply a voltage of 500 VDC between adjacent contact for 1 minute (IEC 60512-3-1)	1000 Megohms [MINIMUM]

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3	Dielectric Withstanding Voltage	Unmated connectors: apply a voltage of 500 VAC between adjacent contact for 1 minute (IEC 60512-4-1)	No voltage breakdown
4	Temperature Rise	Mated and measure the temperature rise of contact, when rated current is passed. (IEC 60512-5-1)	Temperature Rise +30°C [MAXIMUM]

6.2 MECHANICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
5	Contact Normal Force	Measure contact normal force at 0.30mm away from housing top surface. (refer to Appendix 2). Reading to be taken from returned curve.	0.30N min at 0.3mm away from housing top surface
6	Durability	Mate connectors at 240-550 cycles/hour to 500 cycles. Horizontal insertion for max deflection case.	Contact resistance 100 milliohms [MAXIMUM] Contact Normal Force within spec. (refer to Appendix 1&3)
7	Solder Joint Peeling Strength	Apply a load to the connector parallel to the PWB (X & Y direction)	20 N [MINIMUM]
8	Resistance to Soldering Condition	Unmated sample to be passed through reflow over according to temp profiles (shown in section 9.0)	No mechanical damage

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6.3 ENVIRONMENTAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION		R	EQUIREME	NT
9	Dry cold (steady state)	At -40°C for 96 hours Recovery: 2 hours at ambie (IEC60068-2-1Ab)	ent atmosphere	Conta	act resistand milliohms [MAXIMUM	
10	Dry heat (steady state)	At +85°C for 96 hours Recovery: 2 hours at ambie (IEC60068-2-2Bb)	ent atmosphere	Conta	ce 100]	
11	Thermal Shock	25 cycle at Ta = -55°C for 0 change of temp = 25°C MA T_b = +85°C for 0.5hour, the ambient Recovery: 2hours at ambie (IEC60068-2-14 Test Na)	X 5min, then, n cool to	n, contact area Contact resistance		ation at a ce 100
12	Humidity Cyclic	Cycle the parts between 25 80% ± 3% RH and 65 °C ± 3% RH. Ramp times should be 0.5 I times should be 1.0 hour. Dwell times start when the and humidity have stabilize specified levels. Perform 24 cycles. (EIA-364-1000.01A)	3 °C at 50% ± hour and dwell temperature	Insulat	act resistanc milliohms [MAXIMUM ion resistanc Megohms [MINIMUM] oltage break] ce 1000
13	Salt Spray	95%, Salt NaCl mist 5% aft				
	I					
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14	Vibration (Random)	Frequency: 10~100 Hz, 0.0132 g2/Hz; Frequency: 100~500Hz, -3dB/Oct Applied for 1 hours in each 3 mutually perpendicular axes (IEC60068-2-64 Fh)	Contact resistance 100 milliohms [MAXIMUM] Discontinuity < 1 μs	
15	Shock (specified pulse)	Pulse shape = half sine Peak acceleration = 490m/s ² (50G) Duration of pulse = 11ms Apply 3 successive shocks in each direction along the 3 mutually perpendicular axes. (IEC-60068-2-27 EA)	Contact resistance 100 milliohms [MAXIMUM] Discontinuity < 1 μs	
16	Solderability	Solder paste is deposited on a ceramic plate via stencil. The connectors are steam aged and placed onto the solder paste print. The substrate is processed through a forced hot convection oven. The connectors are removed from the ceramic and inspected. Steam Aging: 1 hour (ANSI-J-STD 002)	No bridging and good coverage	

7.0 PACKAGING

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Parts shall be packaged to protect against damage during handling, transit and storage. The parts shall be carried in reels inside boxes. For details, kindly refer to Packaging spec PK-78545-001 and Sale drawing SD-78545-003.

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8.0 TEST SEQUENCES

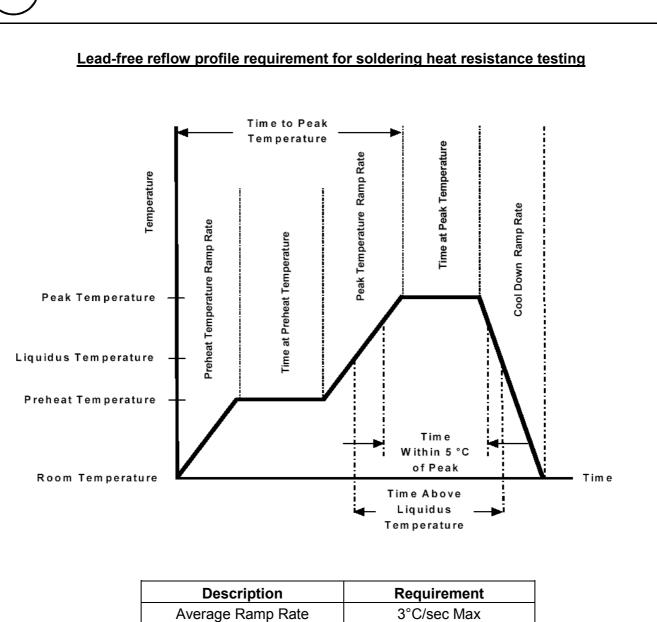
Test Group →	Grp1 (screen test)	Grp2	Grp3	Grp4 (screen test)	Grp5	Grp6 (screen test)	Grp7	Grp8
Test or Examination $oldsymbol{\Psi}$								
Sample size	5	5	5	5	5	5	5	5
Resistance to Soldering Conditions	1	1	1	1	1		1	1
Contact Resistance	2,5	2,7	2,4				2,5	2,5
Insulation Resistance		3,8						
Dielectric Withstanding Voltage		4,9						
Temperature Rise					2			
Contact Normal Force	3,6							
Durability	4							
Solder Joint Peeling Strength				2				
Dry Cold							3	
Dry Heat							4	
Thermal Shock		5						
Cyclic Humidity		6						
Salt Spray			3					
Vibration								3
Shock								4
Solderability						1		

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9.0 SOLDERING PROFILE Lead-free reflow profile requirement for solderability testing Time to Peak Temperature Time at Peak Temperature Peak Temperature Ramp Rate Temperature Cool Down Ramp Rate Preheat Temperature Ramp Rate **Time at Preheat Temperature** Peak Temperature Liquidus Temperature Preheat Temperature Time Within 5 °C ofPeak Room Temperature Time Time Above Liquidus Tem perature Description Requirement Average Ramp Rate 3°C/sec Max Preheat Temperature 150°C Min to 180°C Max **Preheat Time** 60 to 120 sec 3°C/sec Max Ramp to Peak 30 sec Max Time over Liquidus (217°C) 230 -0/+5°C **Peak Temperature** Time within 5°C of Peak 10 sec Ramp - Cool Down 5°C/sec Max REVISION: ECR/ECN INFORMATION: TITLE: SHEET No. SIM CARD CONNECTOR, BLOCK EC No: S2013-0844 SIM, 0.30mm HEIGHT 7 of 10 Α DATE: 2013/06/03 DOCUMENT NUMBER: CREATED / REVISED BY: CHECKED BY: APPROVED BY: PS-78545-002 May Soo 2013/05/16 Jtan 2013/06/20 Victor Lim 2013/06/20 TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A4](V.1).DOC





Description	Requirement
Average Ramp Rate	3°C/sec Max
Preheat Temperature	150°C Min to 180°C Max
Preheat Time	120 to 180 sec
Ramp to Peak	3°C/sec Max
Time over Liquidus (217°C)	65 to 150 sec Max
Peak Temperature	255 -0/+5°C
Time within 5°C of Peak	10 sec
Ramp - Cool Down	5°C/sec Max
Time 40°C to 220	3 to 8 Min

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